

Notice of References Cited

Application/Control No.

10/552,308

Applicant(s)/Patent Under
Reexamination
KAMIMURA ET AL.

Examiner

Charles E. Cooley

Art Unit

1797

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,877,682 A	04-1975	Moss, Lester I.	366/132
*	B	US-4,219,038 A	08-1980	Lubitzsch et al.	137/7
*	C	US-4,277,254 A	07-1981	Hanson, Robert C.	48/189.1
*	D	US-4,420,008 A	12-1983	Shu, Winston R.	137/4
*	E	US-4,776,977 A	10-1988	Taylor, Spencer E.	516/53
*	F	US-4,964,732 A	10-1990	Cadeo et al.	366/152.1
*	G	US-5,332,311 A	07-1994	Volk et al.	366/134
*	H	US-5,372,421 A	12-1994	Pardikes, Dennis	366/137
*	I	US-5,482,368 A	01-1996	Nakamura et al.	366/152.2
*	J	US-5,968,268 A	10-1999	Kitano et al.	118/52
*	K	US-6,050,283 A	04-2000	Hoffman et al.	137/3
*	L	US-6,224,778 B1	05-2001	Peltzer, Charles T.	210/739
*	M	US-6,280,692 B1	08-2001	Bartlett, Jr., Henry Walker	422/131

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 62129135 A	06-1987	Japan	NISHITARUMI et al.	B01F 11/00
	O	JP 01047434 A	02-1989	Japan	DOI et al.	B01F 15/04
	P	JP 07198554 A	08-1995	Japan	KRONEIS et al.	G01N 01/00
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
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	X					

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0044494 A1	04-2002	Steinberger et al.	366/152.1
*	B	US-2002/0144727 A1	10-2002	Kashkoush et al.	137/93
*	C	US-6,494,608 B1	12-2002	Retamal et al.	366/132
*	D	US-2003/0031086 A1	02-2003	Shikami et al.	366/160.2
*	E	US-2003/0198125 A1	10-2003	Linsen et al.	366/152.1
*	F	US-6,767,124 B2	07-2004	Shikami et al.	366/152.2
*	G	US-2004/0141409 A1	07-2004	Breithaupt, Hartmut	366/152.2
*	H	US-6,799,883 B1	10-2004	Urquhart et al.	366/152.4
*	I	US-6,923,568 B2	08-2005	Wilmer et al.	366/152.1
*	J	US-2005/0219945 A1	10-2005	Kelley et al.	366/142
*	K	US-2006/0285429 A1	12-2006	Kamimura et al.	366/160.2
*	L	US-7,377,685 B2	05-2008	Breithaupt, Hartmut	366/152.2
*	M	US-2008/0198689 A1	08-2008	Breithaupt, Hartmut	366/152.2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

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